


<b>Search Notes</b> 	<b>Application/Control No.</b> 10574736	<b>Applicant(s)/Patent Under Reexamination</b> DOI ET AL.
	<b>Examiner</b> MARCOS BATISTA	<b>Art Unit</b> 2617

SEARCHED			
Class	Subclass	Date	Examiner
455	41.2	8/1/2008	mb
455	41.3	8/1/2008	mb
455	574	8/1/2008	mb

SEARCH NOTES			
Search Notes		Date	Examiner
Consulted with Rafael Perez Gutierrez		8/4/2008	mb
East Search		8/1/2008	mb

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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